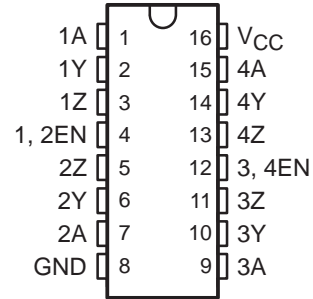


SN55ALS194, SN75ALS194 QUADRUPLE DIFFERENTIAL LINE DRIVERS

SLLS009D – OCTOBER 1985 – REVISED MAY 1995

- Meet or Exceed the Requirements of ANSI Standard EIA/TIA-422-B and ITU Recommendation V.11
- Designed to Operate Up to 20 Mbaud
- 3-State TTL-Compatible Outputs
- Single 5-V Supply Operation
- High Output Impedance in Power-Off Condition
- Two Pairs of Drivers, Independently Enabled
- Designed as Improved Replacements for the MC3487

SN55ALS194 . . . J OR W PACKAGE
SN75ALS194 . . . D OR N PACKAGE
(TOP VIEW)



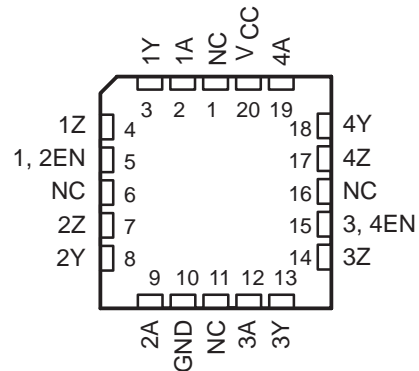
description

These four differential line drivers are designed for data transmission over twisted-pair or parallel-wire transmission lines. They meet the requirements of ANSI Standard EIA/TIA-422-B and ITU Recommendation V.11 and are compatible with 3-state TTL circuits. Advanced low-power Schottky technology provides high speed without the usual power penalty. Standby supply current is typically only 26 mA. Typical propagation delay time is less than 10 ns, and enable/disable times are typically less than 16 ns.

High-impedance inputs keep input currents low: less than 1 μ A for a high level and less than 100 μ A for a low level. The driver circuits can be enabled in pairs by separate active-high enable inputs. The SN55ALS194 and SN75ALS194 are capable of data rates in excess of 20 megabits per second and are designed to operate with the SN55ALS195 and SN75ALS195 quadruple line receivers.

The SN55ALS194 is characterized for operation over the full military temperature range of -55°C to 125°C . The SN75ALS194 is characterized for operation from 0°C to 70°C .

SN55ALS194 . . . FK PACKAGE
(TOP VIEW)



NC – No internal connection

FUNCTION TABLE
(each driver)

INPUTS A	OUTPUT EN	OUTPUTS	
		Y	Z
H	H	H	L
L	H	L	H
X	L	Z	Z

H = high level, L = low level, X = irrelevant,
Z = high impedance



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

 **TEXAS
INSTRUMENTS**

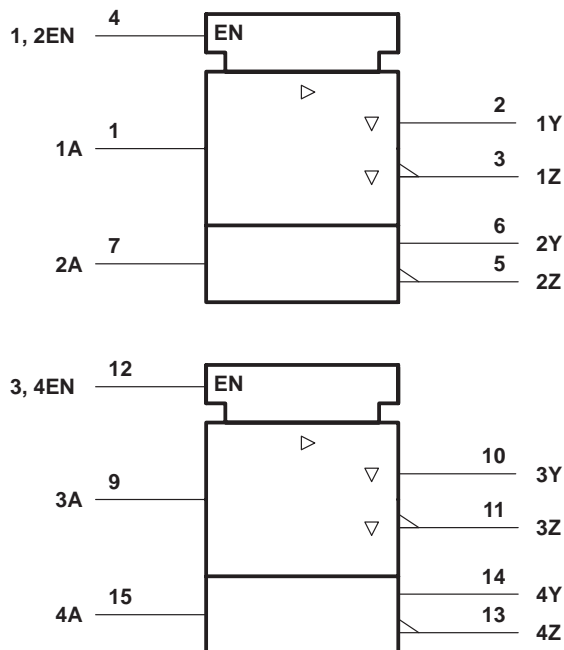
POST OFFICE BOX 655303 • DALLAS, TEXAS 75265

Copyright © 1995, Texas Instruments Incorporated

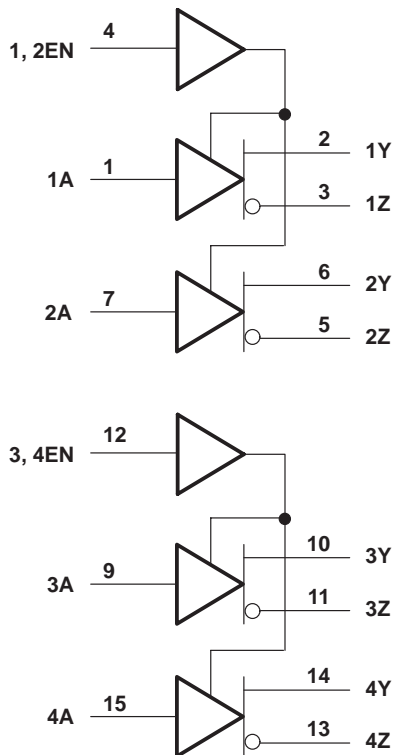
SN55ALS194, SN75ALS194 QUADRUPLE DIFFERENTIAL LINE DRIVERS

SLLS009D – OCTOBER 1985 – REVISED MAY 1995

logic symbol†



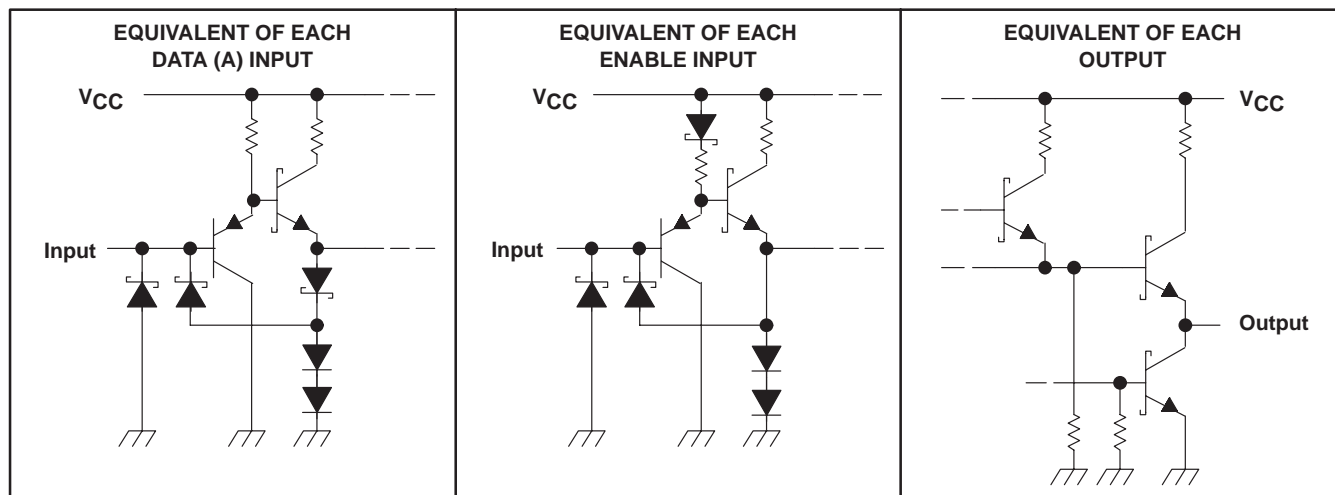
logic diagram (positive logic)



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, J, N, and W packages.

schematics of inputs and outputs



SN55ALS194, SN75ALS194 QUADRUPLE DIFFERENTIAL LINE DRIVERS

SLLS009D – OCTOBER 1985 – REVISED MAY 1995

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V_{CC} (see Note 1)	7 V
Input voltage, V_I	5.5 V
Output voltage, V_O	7 V
Continuous total dissipation	See Dissipation Rating Table
Operating free-air temperature range, T_A : SN55ALS194	– 55°C to 125°C
SN75ALS194	0°C to 70°C
Storage temperature range, T_{stg}	– 65°C to 150°C
Case temperature for 60 seconds, T_C : FK package	260°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: D, N, or W package	260°C
Lead temperature 1,6 mm (1/16 inch) from case for 60 seconds: J package	300°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to network ground terminal

DISSIPATION RATING TABLE

PACKAGE	$T_A \leq 25^\circ\text{C}$	DERATING FACTOR ABOVE $T_A = 25^\circ\text{C}$	$T_A = 70^\circ\text{C}$	$T_A = 125^\circ\text{C}$
	POWER RATING		POWER RATING	POWER RATING
D	950 mW	7.6 mW/°C	608 mW	N/A
FK	1375 mW	11.0 mW/°C	880 mW	275 mW
J	1375 mW	11.0 mW/°C	880 mW	275 mW
N	1150 mW	9.2 mW/°C	736 mW	N/A
W	1000 mW	8.0 mW/°C	640 mW	200 mW

recommended operating conditions‡

	SN55ALS194			SN75ALS194			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, V_{CC}	4.5	5	5.5	4.75	5	5.25	V
High-level input voltage, V_{IH}	All inputs, $T_A = 25^\circ\text{C}$		2	2		V	
	A inputs, $T_A = \text{Full range}$		2	2			
	EN inputs, $T_A = \text{Full range}$		2.1	2			
Low-level input voltage, V_{IL}			0.8	0.8		V	
High-level output current, I_{OH}			– 20	– 20		mA	
Low-level output current, I_{OL}	$T_A = 25^\circ\text{C}$		48	48		mA	
	$T_A = \text{Full range}$		20	48			
Operating free-air temperature, T_A	– 55	125	0	70	°C		

‡ Full range is $T_A = -55^\circ\text{C}$ to 125°C for SN55ALS194 and $T_A = 0^\circ\text{C}$ to 70°C for SN75ALS194.

SN55ALS194, SN75ALS194 QUADRUPLE DIFFERENTIAL LINE DRIVERS

SLLS009D – OCTOBER 1985 – REVISED MAY 1995

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†		MIN	TYP‡	MAX	UNIT
V _{IK}	Input clamp voltage	V _{CC} = MIN,	I _I = -18 mA			-1.5	V
V _{OH}	High-level output voltage	V _{CC} = MIN, I _{OH} = -20 mA	SN55ALS194	2.4			V
			SN75ALS194	2.5			
V _{OL}	Low-level output voltage	V _{CC} = MIN,	I _{OL} = MAX			0.5	V
V _O	Output voltage	I _O = 0		0		6	V
V _{OD1}	Differential output voltage	I _O = 0		1.5		6	V
V _{OD2}	Differential output voltage	R _L = 100 Ω, See Figure 1		1/2 V _{OD1} or 2§			V
Δ V _{OD}	Change in magnitude of differential output voltage¶					±0.4	V
V _{OC}	Common-mode output voltage					±3	V
Δ V _{OC}	Change in magnitude of common-mode output voltage¶					±0.4	V
I _O	Output current with power off	V _{CC} = 0	V _O = 6 V			100	μA
			V _O = -0.25 V			-100	
I _{OZ}	High-impedance-state output current	V _{CC} = MAX, Output enables at 0.8 V	V _O = 2.7 V			100	μA
			V _O = 0.5 V			-100	
I _I	Input current at maximum input voltage	V _{CC} = MAX,	V _I = 5.5 V			100	μA
I _{IH}	High-level input current	V _{CC} = MAX,	V _I = 2.7 V			50	μA
I _{IL}	Low-level input current	V _{CC} = MAX,	V _I = 0.5 V			-200	μA
I _{OS}	Short-circuit output current#	V _{CC} = MAX,	V _I = 2 V	-40		-140	mA
I _{CC}	Supply current (all drivers)	V _{CC} = MAX,	All outputs disabled		26	45	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at V_{CC} = 5 V, T_A = 25°C.

§ The minimum V_{OD2} with a 100-Ω load is either 1/2 V_{OD1} or 2 V, whichever is greater.

¶ Δ|V_{OD}| and Δ|V_{OC}| are the changes in magnitude of V_{OD} and V_{OC}, respectively, that occur when the input is changed from a high level to a low level.

Not more than one output should be shorted at a time, and duration of the short circuit should not exceed one second.

switching characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER	TEST CONDITIONS	SN55ALS194			SN75ALS194			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	
t _{PLH}	Propagation delay time, low- to high-level output		6	13		6	13	ns
t _{PHL}	Propagation delay time, high- to low-level output		9	14		9	14	ns
	Output-to-output skew		3.5	6		3.5	6	ns
t _{t(OD)}	Differential output transition time		8	14		8	14	ns
t _{PZH}	Output enable time to high level		9	12		9	12	ns
t _{PZL}	Output enable time to low level		12	20		12	20	ns
t _{PHZ}	Output disable time from high level		9	15		9	14	ns
t _{PLZ}	Output disable time from low level		12	15		12	15	ns



POST OFFICE BOX 655303 • DALLAS, TEXAS 75265

SN55ALS194, SN75ALS194 QUADRUPLE DIFFERENTIAL LINE DRIVERS

SLLS009D – OCTOBER 1985 – REVISED MAY 1995

SYMBOL EQUIVALENTS

DATA SHEET PARAMETER	EIA/TIA-422-B
V_O	V_{oa}, V_{ob}
$ V_{OD1} $	V_o
$ V_{OD2} $	$V_t (R_L = 100 \Omega)$
$\Delta V_{OD} $	$ V_t - \bar{V}_t $
V_{OC}	$ V_{os} $
$\Delta V_{OC} $	$ V_{os} - \bar{V}_{os} $
I_{OS}	$ I_{sa} , I_{sb} $
I_O	$ I_{xa} , I_{xb} $

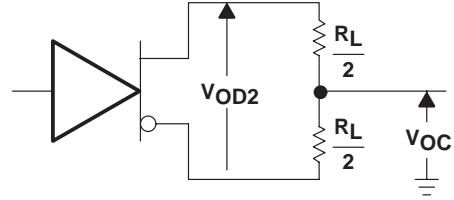
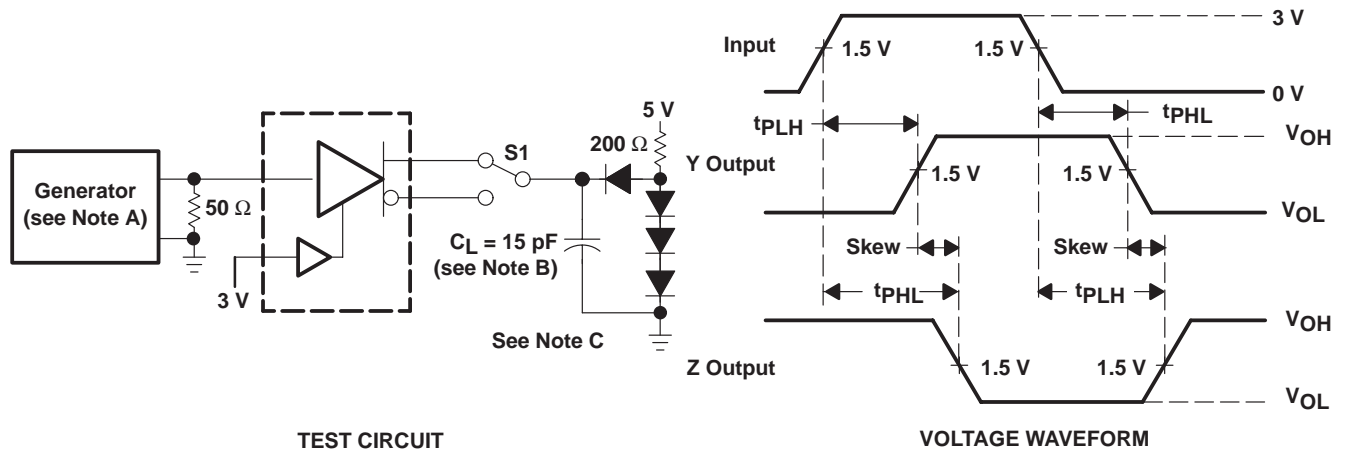


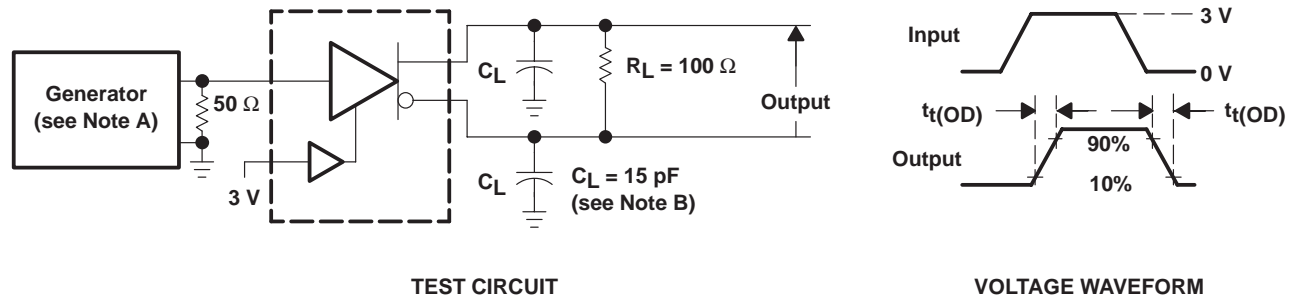
Figure 1. Driver V_{OD} and V_{OC}

PARAMETER MEASUREMENT INFORMATION



- NOTES: A. The input pulse is supplied by a generator having the following characteristics: $t_r \leq 5$ ns, $t_f \leq 5$ ns, $PRR \leq 1$ MHz, duty cycle $\leq 50\%$, $Z_O \approx 50 \Omega$.
 B. C_L includes probe and stray capacitance.
 C. All diodes are 1N916 or 1N3064.

Figure 2. Test Circuit and Voltage Waveform



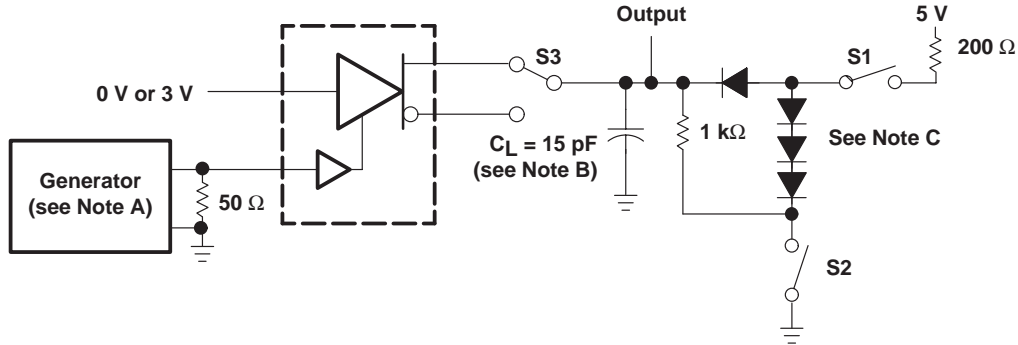
- NOTES: A. The input pulse is supplied by a generator having the following characteristics: $t_r \leq 5$ ns, $t_f \leq 5$ ns, $PRR \leq 1$ MHz, duty cycle $\leq 50\%$, $Z_O \approx 50 \Omega$.
 B. C_L includes probe and stray capacitance.

Figure 3. Differential-Output Test Circuit and Voltage Waveform

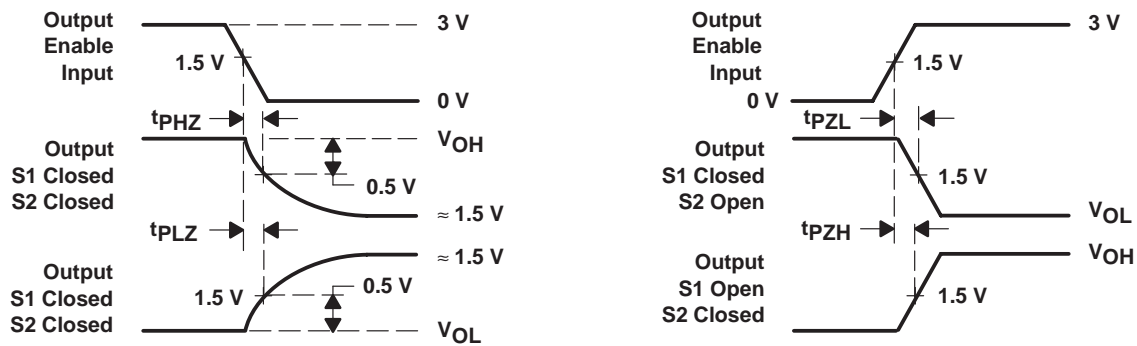
SN55ALS194, SN75ALS194 QUADRUPLE DIFFERENTIAL LINE DRIVERS

SLLS009D – OCTOBER 1985 – REVISED MAY 1995

PARAMETER MEASUREMENT INFORMATION



TEST CIRCUIT



VOLTAGE WAVEFORMS

- NOTES: A. The input pulse is supplied by a generator having the following characteristics: $t_r \leq 5$ ns, $t_f \leq 5$ ns, PRR ≤ 1 MHz, duty cycle $\leq 50\%$, $Z_0 \approx 50 \Omega$.
 B. C_L includes probe and stray capacitance.
 C. All diodes are 1N916 or 1N3064.

Figure 4. Driver Test Circuit and Voltage Waveforms

TYPICAL CHARACTERISTICS†

Y OUTPUT VOLTAGE
 vs
 DATA INPUT VOLTAGE

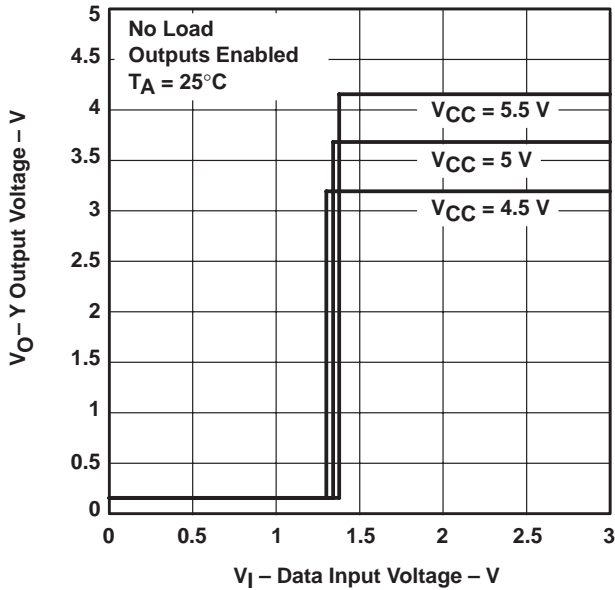


Figure 5

Y OUTPUT VOLTAGE
 vs
 DATA INPUT VOLTAGE

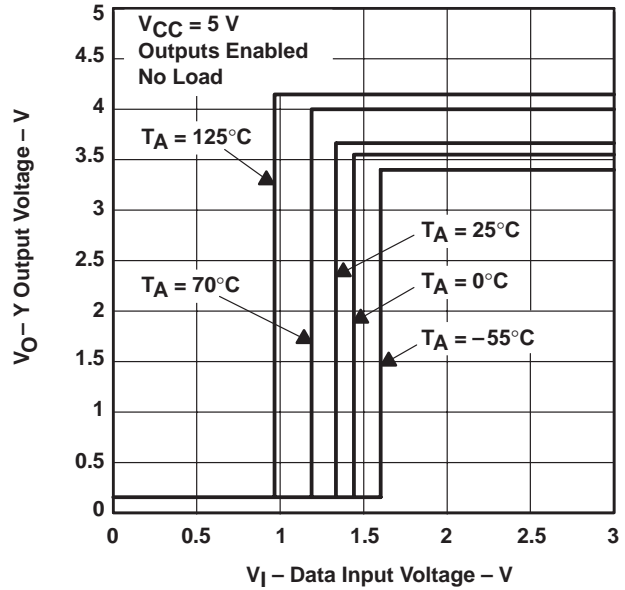


Figure 6

Y OUTPUT VOLTAGE
 vs
 ENABLE G INPUT VOLTAGE

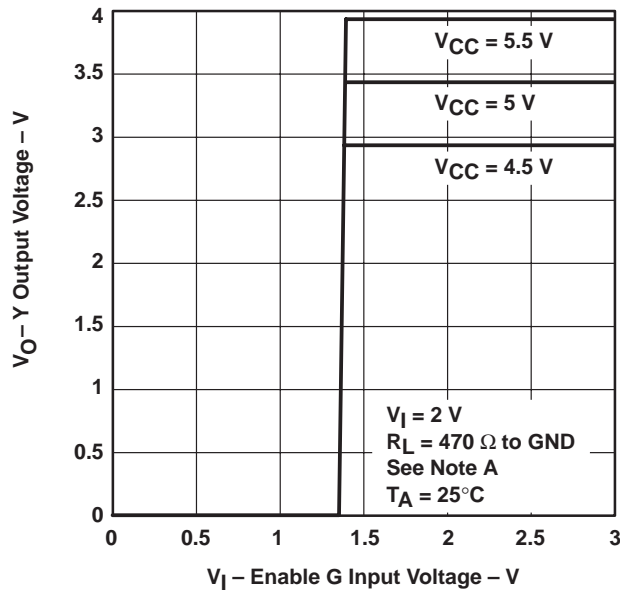


Figure 7

Y OUTPUT VOLTAGE
 vs
 ENABLE G INPUT VOLTAGE

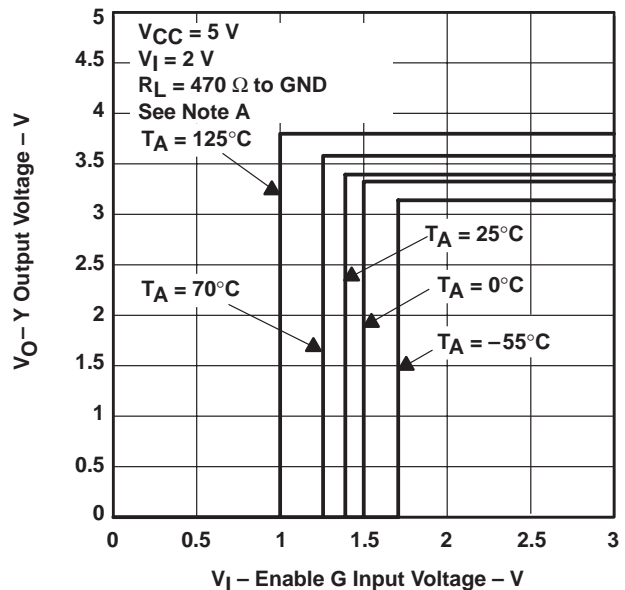


Figure 8

† Data for temperatures below 0°C and above 70°C are applicable to the SN55ALS194 circuits only.

NOTE A: The A input is connected to V_{CC} during the testing of the Y outputs and to GND during the testing of the Z outputs.

SN55ALS194, SN75ALS194 QUADRUPLE DIFFERENTIAL LINE DRIVERS

SLLS009D – OCTOBER 1985 – REVISED MAY 1995

TYPICAL CHARACTERISTICS†

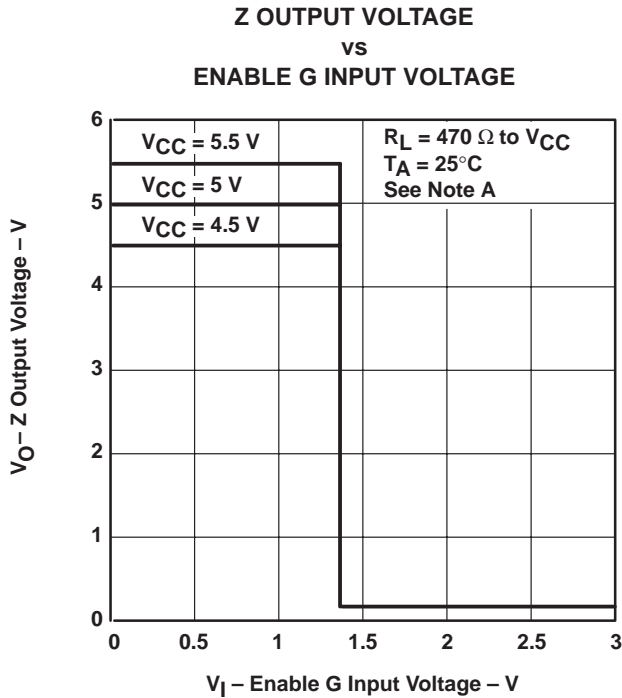


Figure 9

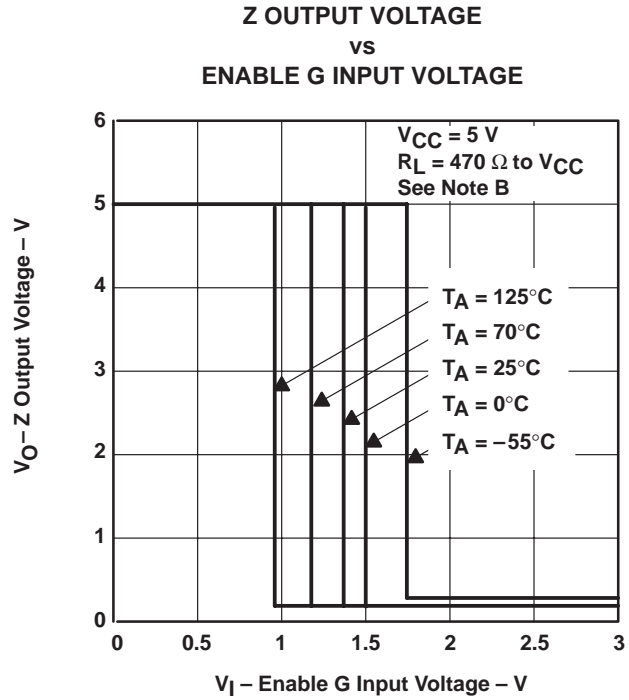


Figure 10

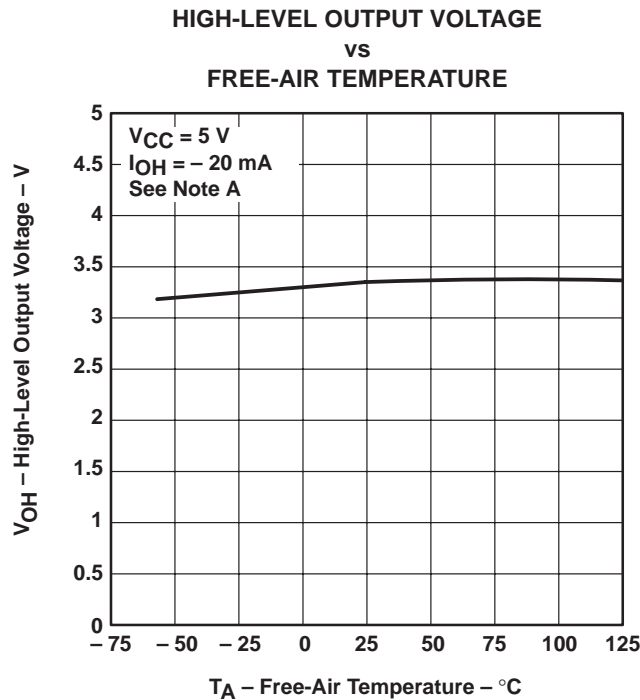


Figure 11

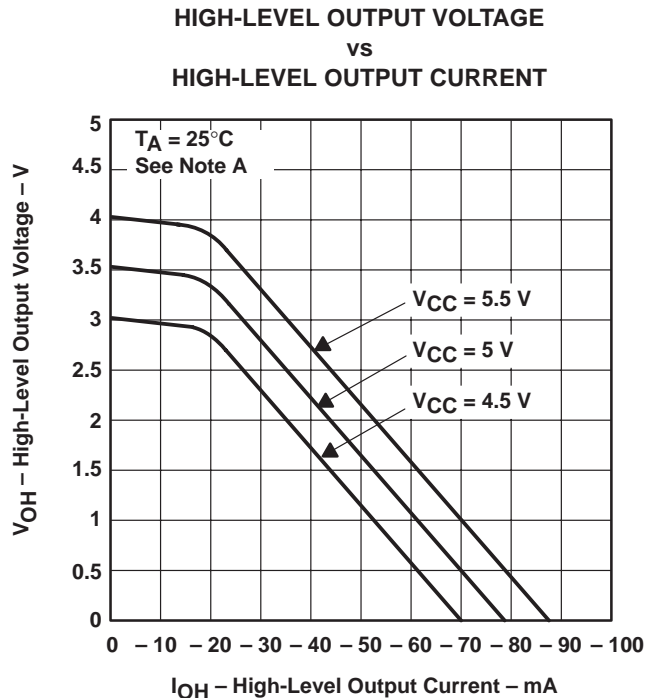


Figure 12

† Data for temperatures below 0°C and above 70°C are applicable to the SN55ALS194 circuits only.

NOTES: A. The A input is connected to V_{CC} during the testing of the Y outputs and to GND during the testing of the Z outputs.

B. The A input is connected to ground during the testing of the Y outputs and to V_{CC} during the testing of the Z outputs.

TYPICAL CHARACTERISTICS†

LOW-LEVEL OUTPUT VOLTAGE
 vs
 FREE-AIR TEMPERATURE

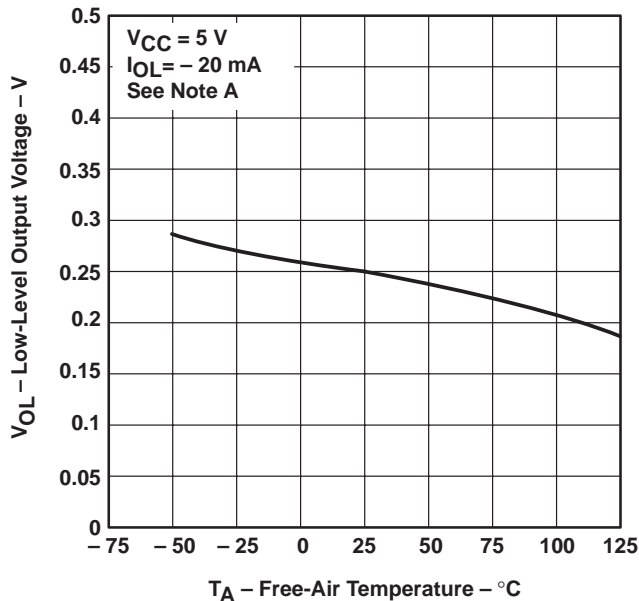


Figure 13

LOW-LEVEL OUTPUT VOLTAGE
 vs
 LOW-LEVEL OUTPUT CURRENT

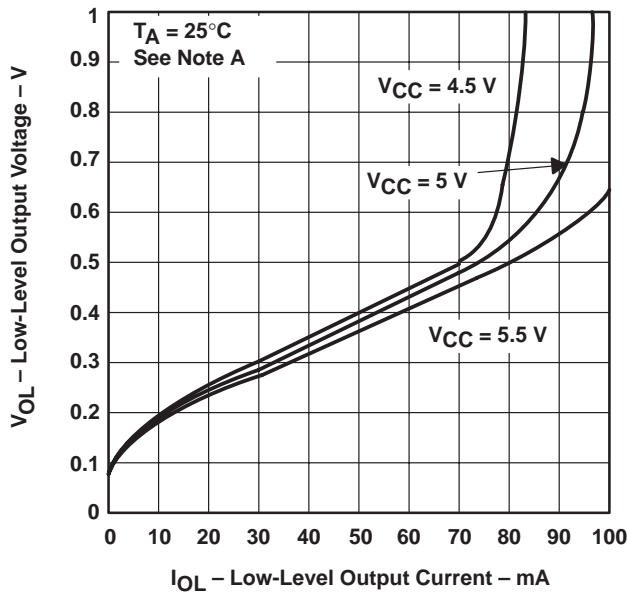


Figure 14

NOTE A: The A input is connected to GND during the testing of the Y outputs and to V_{CC} during the testing of the Z outputs.

SUPPLY CURRENT
 vs
 SUPPLY VOLTAGE

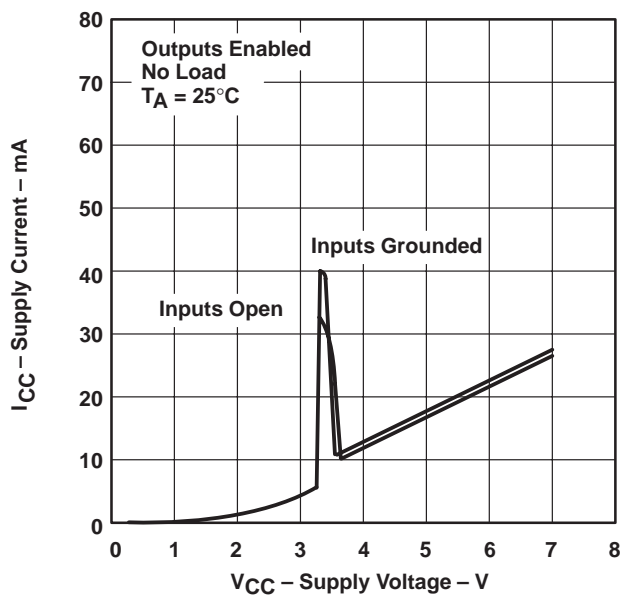


Figure 15

SUPPLY CURRENT
 vs
 SUPPLY VOLTAGE

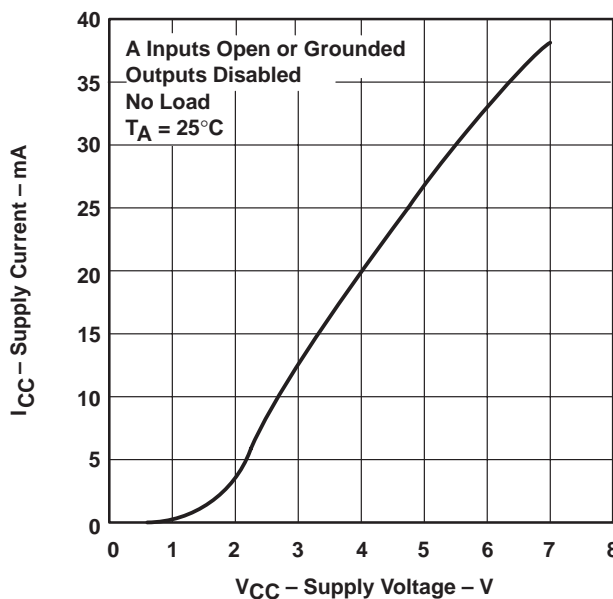


Figure 16

† Data for temperatures below 0°C and above 70°C are applicable to the SN55ALS194 circuits only.

SN55ALS194, SN75ALS194 QUADRUPLE DIFFERENTIAL LINE DRIVERS

SLLS009D – OCTOBER 1985 – REVISED MAY 1995

TYPICAL CHARACTERISTICS

SUPPLY CURRENT vs FREQUENCY

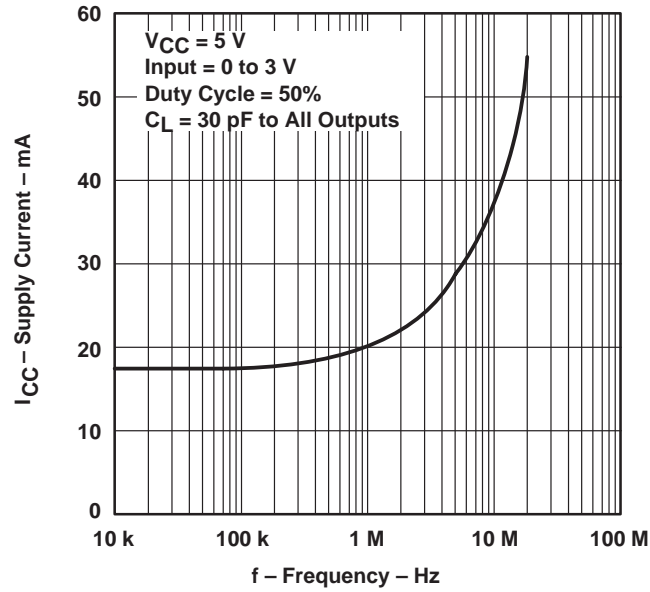


Figure 17

IMPORTANT NOTICE

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgement, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its semiconductor products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

CERTAIN APPLICATIONS USING SEMICONDUCTOR PRODUCTS MAY INVOLVE POTENTIAL RISKS OF DEATH, PERSONAL INJURY, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE ("CRITICAL APPLICATIONS"). TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS. INCLUSION OF TI PRODUCTS IN SUCH APPLICATIONS IS UNDERSTOOD TO BE FULLY AT THE CUSTOMER'S RISK.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, warranty or endorsement thereof.